

2003/3/7

ISE ELECTRONICS CORP.

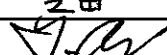
PRODUCTS END. DEPT.

Reliability prediction of GU128X32-820

DS-751-1000-00

[T_a = 25°C]

部品名	Qty. (np)	Fail. Rate(Fit) (p) x 10E-9	np * p(Fit) x 10E-9
Gate Arrey	1	101.8	101.8
ROM	1	100	100
C-MOS IC/TTLIC	3	22	66
Other IC	2	2	4
Transistor	4	2	8
Diode & Zener	5	10	50
Capasitor Electr AL	1	20	20
Capasitor Ceramic	28	0.41	11.48
Resistor Fixed	36	0.025	0.9
Resistor Network	5	0.028	0.14
transformer	1	30	30
Coil	2	2	4
FAR	1	30	30
Fuse	1	10	10
PC Board	1	10	10
Connector (26pin)	1	0.96	0.96
Connector (3pin)	1	3.6	3.6
VFD	1	600	600
Soldering Point (SMD)	386	0.069	26.634
Soldering Point (other)	57	2.6	148.2
Total (Fit)	-	-	1225.714
MTBF (Hrs)	-	-	815,851

	SIGN	DATE
APP	杉田	2003.3.7
CH	笠田	2003.3.7
DR		2003.3.7